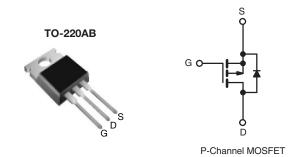


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	- 2	- 200			
R _{DS(on)} (Max.) (Ω)	V _{GS} = - 10 V	0.80			
Q _g (Max.) (nC)	2	29			
Q _{gs} (nC)	5.	5.4			
Q _{gd} (nC)	1:	15			
Configuration	Sin	Single			



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION				
Package	TO-220AB			
Lead (Pb)-free	IRF9630PbF			
Lead (FD)-life	SiHF9630-E3			
SnPb	IRF9630			
SILD	SiHF9630			

PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V_{DS}	- 200	V
Gate-Source Voltage	V_{GS}	± 20	7 v	
Continuous Drain Current	V_{GS} at - 10 V $T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 100 ^{\circ}\text{C}$	1	- 6.5	А
Continuous Drain Current	V_{GS} at - 10 V $T_{C} = 100 ^{\circ}\text{C}$	I _D	- 4.0	
Pulsed Drain Current ^a	I _{DM}	- 26		
Linear Derating Factor		0.59	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	500	mJ	
Repetitive Avalanche Current ^a	I _{AR}	- 6.4	Α	
Repetitive Avalanche Energy ^a	E _{AR}	7.4	mJ	
Maximum Power Dissipation	T _C = 25 °C		74	W
Peak Diode Recovery dV/dt ^c	dV/dt	- 5.0	V/ns	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to + 150	00	
Soldering Recommendations (Peak Temperature)		300 ^d	°C	
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in
	6-32 of M3 screw		1.1	N⋅m

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = -50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 17 \,^{\circ}\text{mH}$, $R_q = 25 \,^{\circ}\Omega$, $I_{AS} = -6.5 \,^{\circ}\text{A}$ (see fig. 12).
- c. $I_{SD} \le -6.5 \text{ A}$, $dI/dt \le 120 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.7		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA		- 200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	o 25 °C, I _D = - 1 mA	-	- 0.24	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_0$	_{GS} , I _D = - 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I _{GSS}	Vo	_{SS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		200 V, V _{GS} = 0 V V _{GS} = 0 V, T _J = 125 °C	-	-	- 100 - 500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V		-	-	0.80	Ω
Forward Transconductance	9 _{fs}	V _{DS} = - 5	50 V, I _D = - 3.9 A ^b	2.8	-	-	S
Dynamic				ı	·		ı
Input Capacitance	C _{iss}	Ι ,	/ -0.1/	-	700	-	pF
Output Capacitance	C _{oss}	V _D	$V_{GS} = 0 \text{ V},$ $v_{OS} = -25 \text{ V},$	-	200	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0	MHz, see fig. 5	-	40	-	
Total Gate Charge	Qg		I _D = - 6.5 A,	-	-	29	nC
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V	$V_{DS} = -160 \text{ V},$	-	-	5.4	
Gate-Drain Charge	Q _{gd}		see fig. 6 and 13 ^b		-	15	1
Turn-On Delay Time	t _{d(on)}	V_{DD} = - 100 V, I_D = - 6.5 A, R_g = 12 Ω , R_D = 15 Ω , see fig. 10 ^b		-	12	-	- ns
Rise Time	t _r			-	27	-	
Turn-Off Delay Time	t _{d(off)}			-	28	-	
Fall Time	t _f			-	24	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		_	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 6.5	^
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 26	A
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = -6.5 A, V _{GS} = 0 V ^b		-	-	- 6.5	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = -6.5 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s}^b$		-	200	300	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.9	2.9	μC
Forward Turn-On Time	t _{on}	Intrinsic turn	on is do	ninated b	y L _S and	L _D)	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

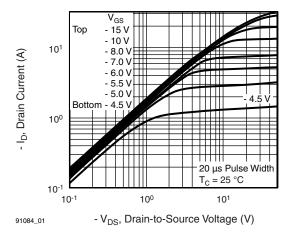


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

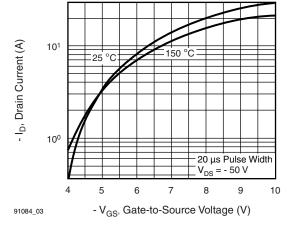


Fig. 3 - Typical Transfer Characteristics

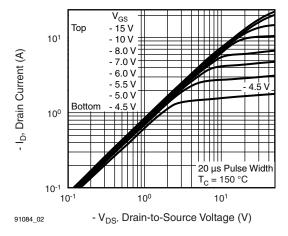


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

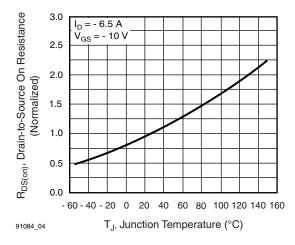


Fig. 4 - Normalized On-Resistance vs. Temperature



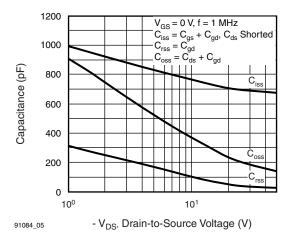


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

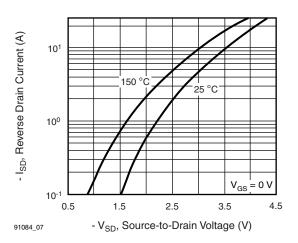


Fig. 7 - Typical Source-Drain Diode Forward Voltage

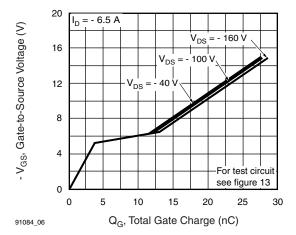


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

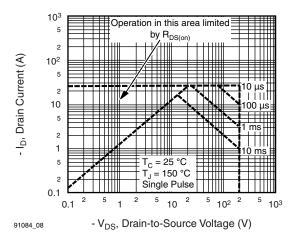


Fig. 8 - Maximum Safe Operating Area



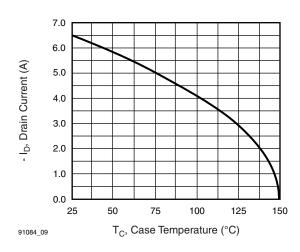


Fig. 9 - Maximum Drain Current vs. Case Temperature

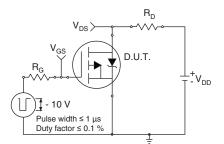


Fig. 10a - Switching Time Test Circuit

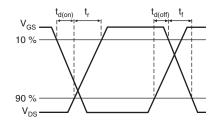


Fig. 10b - Switching Time Waveforms

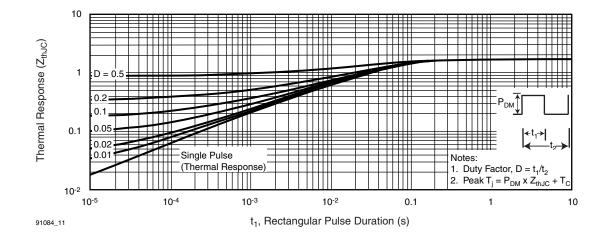


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



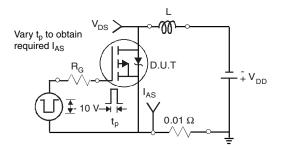


Fig. 12a - Unclamped Inductive Test Circuit

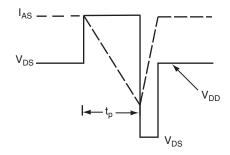


Fig. 12b - Unclamped Inductive Waveforms

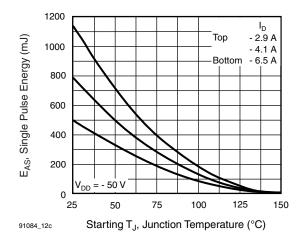


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

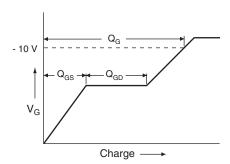


Fig. 13a - Basic Gate Charge Waveform

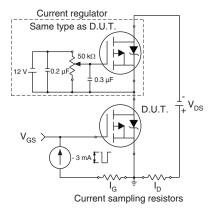
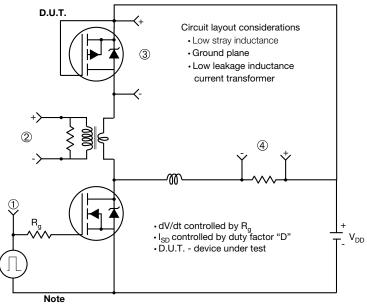


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



· Compliment N-Channel of D.U.T. for driver

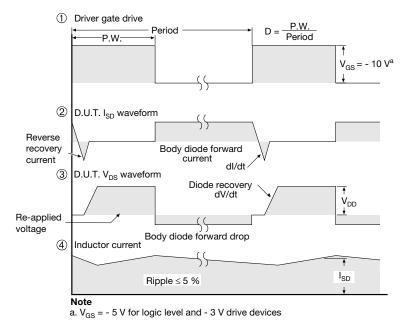


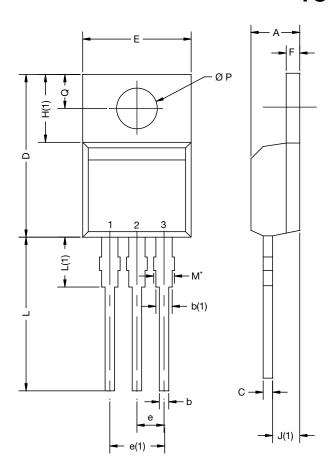
Fig. 14 - For P-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91084.





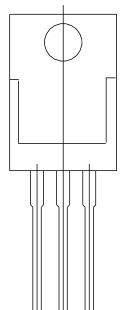
TO-220-1



	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.14	4.70	0.163	0.185	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.73	0.045	0.068	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
Е	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	0.43	1.40	0.017	0.055	
H(1)	6.10	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØР	3.53	3.94	0.139	0.155	
Q	2.59	3.00	0.102	0.118	
ECN: X15-0003-Rev. A, 19-Jan-15 DWG: 6031					

Notes

- M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM
- Outline conforms to JEDEC® outline TO-220AB with exception of dimension F



Revison: 19-Jan-15 1 Document Number: 66542



Legal Disclaimer Notice

Vishay

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Revision: 02-Oct-12 Document Number: 91000